

**Notice of References Cited**

Application/Control No.

09/529,379

Applicant(s)/Patent Under

Reexamination

VAN DER HEIJDEN ET AL.

Examiner

Christian La Forgia

Art Unit

2131

Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,018,766	01-2000	Samuel et al.	709/218
	B	US-5,960,178	09-1999	Cochinwala et al.	709/232
	C	US-5,680,551	10-1997	Martino, II, John A.	709/226
	D	US-5,920,822	07-1999	Houde et al.	455/466
	E	US-6,125,399	09-2000	Hamilton, Patrick	709/245
	F	US-5,530,806	06-1996	Condon et al.	714/49
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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